- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

### description

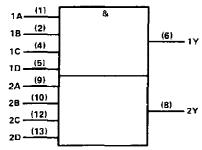
These devices contain two independent 4-input AND gates.

The SN54LS21 is characterized for operation over the full military temperature range of  $-55\,^{\circ}\text{C}$  to 125 $\,^{\circ}\text{C}$ . The SN74LS21 is characterized for operation from 0 $\,^{\circ}\text{C}$  to 70 $\,^{\circ}\text{C}$ .

#### **FUNCTION TABLE (each gate)**

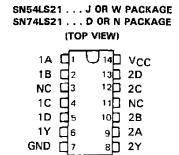
	INP	UTS	ОИТРИТ	
A	В	C	D	Y
Н	н	Н	н	Н
L	Х	х	Х	L
x	Ł	Х	х	L
X	Х	L	×	L
х	X	X	L	L

### logic symbol†

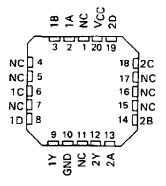


<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

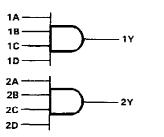


# SN54LS21 . . . FK PACKAGE (TOP VIEW)



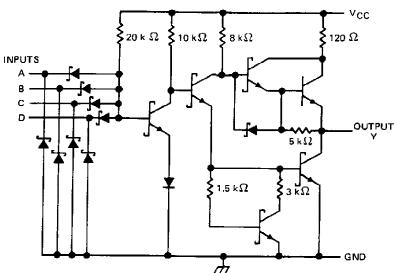
NC-No internal connection

### logic diagram



(positive logic)  $Y = A \cdot B \cdot C \cdot D$  or  $Y = \overline{A + B + \overline{C} + \overline{D}}$ 

### schematics (each gate)



Resistor values shown are nominal.

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	**********************	7 V
Input voltage,	****************	7 V
Operating free-air temperature range:	SN54'55°C	to 125°C
	SN74'	
Storage temperature range		to 150°C

NOTE 1: Voltage values are with respect to network ground terminals.

### recommended operating conditions

	s	SN54LS21			SN74LS21		
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIH High-level input voltage	2			2			٧
V <sub>IL</sub> Low-level input voltage			0.7			9.8	٧
OH High-level output current			- 0.4			- 0.4	mA
IOL Low-level output current			4			8	mΑ
TA Operating free-air temperature	- 55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER VIK			SN54LS21			SN74LS21			l	
		TEST CONDITIONS T			TYP\$	MAX	MIN	TYP‡	MAX	UNIT
	VCC = MIN,	I <sub>I</sub> = — 18 mA			_	- 1.5			- 1.5	٧
v <sub>OH</sub>	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	I <sub>OH</sub> = 0.4 mA	2.5	3.4		2.7	3.4		٧
VOL	V <sub>CC</sub> = MIN,	V <sub>IL</sub> = MAX,	l <sub>OL</sub> = 4 mA		0.25	0.4		0.25	0.4	v
	VCC = MIN,	VIL = MAX,	IOL = 8 mA					0.35	0.5	<u>l</u>
l <sub>1</sub>	VCC = MAX,	V <sub>1</sub> = 7 V				0.1			0.1	mA
(ін	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 2.7 V				20			20	μА
կլ	VCC = MAX,	V <sub>I</sub> = 0.4 V				- 0.4			- 0.4	mA
IOS §	V <sub>CC</sub> = MAX		<u> </u>	- 20		<b>– 100</b>	- 20		- 100	mΑ
<b>І</b> ссн	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 4.5 V			1.2	2.4		1.2	2.4	mΑ
ICCL	VCC = MAX,	V <sub>1</sub> = 0 V	,		2.2	4.4		2.2	4.4	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

# switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS			TYP	мах	UNIT
tPLH		\r	<b>5 6</b> 16	C 15 oc		8	15	ns
tPHL	Any	۲	R <sub>L</sub> = 2 kΩ, C <sub>L</sub> = 15 pF		10	20	ns	

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

<sup>1</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_{\Delta} = 25^{\circ}\text{C}$  § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

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